

A commitment to value in signal generators



Agilent's high performance RF signal generators - choose one for...

...Best spectral purity

8644B

- · 252 kHz to 1030 MHz, 2060 MHz (Option 8644B-002)
- · Lowest SSB phase noise and spurious
- · Highest output power
- · Lowest residual FM
- · AM, FM, pulse modulation
- Built-in 2 GHz counter (Option 8644B-011)
- VOR/ILS signal simulation (Option 8644B-009)
- Ultra low leakage (Option 8644B-010)

...High RF frequency coverage

8664A and 8665B

- 100 kHz to 3000 MHz 8664A, 4200 MHz 8665B 6000 MHz
- · Low SSB phase noise (Option 8664A-004 or Option 8665B-004)
- · AM and wideband FM
- High performance pulse modulation (Option 8664A-008 or Option 8665B-008)
- Ultra low leakage (Option 8664A-010 or Option 8665B-010)

Choose one for your application...

	8644B 1 or 2 GHz	8664A 3 GHz	8665B 6 GHz
RF communications Out-of-channel receiver testing ¹	Ideal for receivers with ≥ 90 dB selectivity and/or spurious immunity of ≥ 85 dB	Ideal for receivers with ≥ 90 dB selectivity with Option 8664A-004, and spurious immunity of < 85 dB to 3 GHz	Same performance as 8664A but up to 6 GHz
General purpose	Lowest possible phase noise and spurious for R&D	Wideband FM with rates to 6 MHz for simulation of many new digital systems	Lowest noise and spurious to 6 GHz
Component test	Highest output power for mixer testing	Ideal clock source with low phase jitter for high speed digital components	Best output level accuracy to 6 GHz for response testing
Radar/EW testing	Full functionality for R&D and manufacturing	Optional pulse modulation with internal delay and width adjust	Same performance as 8664A but up to 6 GHz for coverage of most surveillance radars
Avionics	Option 8644B-009 provides specified VOR/ILS signal simulation	Coverage of most weather and avionics radars. Option 8664A-008 provides pulse modulation capable of generating appropriate pulse width and delay internally	Same performance as 8664A up to 6 GHz

^{1.} For FM receivers with approximately 14 kHz IF BW and 25 kHz channel spacing

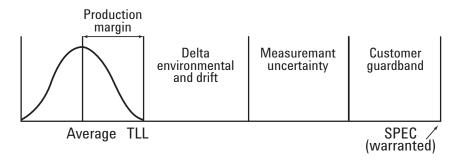
Performance backed by Agilent's reputation and manufacturing experience

Every Agilent Technologies' signal generator meets specifications that would reject most other signal generators

Before any Agilent Technologies' signal generator is introduced, specifications are set to assure that the product will perform consistently for your application. The specification setting process is reflective of the quality that Agilent has always strived to deliver. An explanation of Agilent's specification setting process will show the confidence that you can have when selecting an Agilent Technologies signal generator.

The model used for specification setting is illustrated in the above right figure. The following text defines each element in the figure.

- Production margin is the difference between the average product performance and the test line limit (TLL). This TLL is the pass/fail limit used by the production line at final test under standard environmental conditions.
- Delta environmental represents the possible change in performance over the environmental extremes (e.g., temperature and humidity).



- Drift represents the change in performance over the calibration period.
- Measurement uncertainty accounts for possible measurement errors in the equipment used to characterize the signal generator.
- Customer guardband represents any additional margin necessary to ensure a worst case scenario.

This process means that whether the signal generator is placed in a high temperature environment such as at the top of a rack of equipment or a well controlled environment, the performance stated in our specifications can be relied on for your most exacting applications. This process guarantees that the signal generator is introducing the minimum error possible in the measurements you are performing.

Typical performance

Since some applications push the limits of specifications, Agilent Technologies also provides data that indicates typical performance. This typical performance is generally set at the test line limit (TLL), which is significantly better than the warranted specification. Use the typical data when comparing different products, or when your application pushes the limit on a given specification. The following information highlights typical performance for the most common areas of interest for the 8644B. 8664A and 8665B.

Typical performance, for applications that push specifications

SSB phase noise

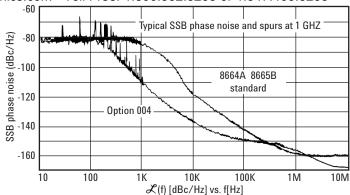
SSB phase noise is an important specification of a signal generator if it is to be used for measuring the adjacent channel selectivity of a receiver. If the phase noise of the signal generator is too high at frequency offsets equal to the channel spacing, the test results might indicate a failure of the receiver when it is actually functioning properly. If the selectivity is ≥ 90 dB, the 8644B (or Option 8664A-004, or Option 8665B-004) is recommended.

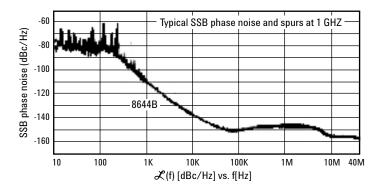
Output level accuracy

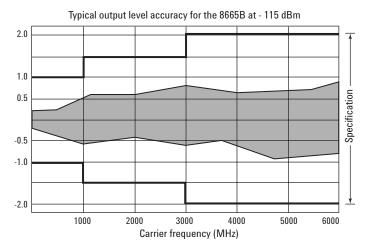
Output level accuracy is a combination of temperature variation, flatness over frequency, and the signal generator's internal attenuator and detector accuracies. The graph represents worst case output level accuracy of a sampling of 8665Bs. All of these units fall within the shaded area.

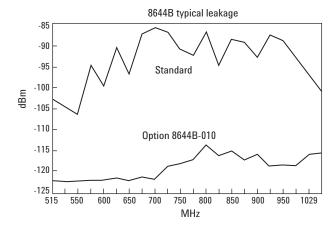
RF leakage

Due to radios becoming more sensitive and operating at higher frequencies, the traditional two-turn loop measurement of RF leakage has become inadequate. To overcome the shortcomings of the twoturn loop, Agilent has developed a new measurement technique using resonant dipole antennas, which is 20 to 25 dB more sensitive than the two-turn loop method. Agilent has been able to reduce the level of radiated emissions in its newer signal generators through innovative design and packaging. Understanding that not all applications require the lowest possible emissions, Option 010 (i.e., 86xxx-010) is available on all of these performance signal generators.









Features that improve the usability of Agilent's 8644B, 8664A and 8665B for your application!



Internal modulation source

- Low distortion sinewaves to 400 kHz with variable phase and amplitude.
- Triangle, sawtooth and squarewaves to 50 kHz with variable phase and amplitude.
- White Gaussian noise with variable amplitude.
- Two independent sources for two-tone testing.

Optional pulse modulation (Options 8664A-008 and 8665B-008)

- An Agilent designed GaAs pulse modulator provides the exceptional performance that is so critical for pulsed applications.
- < 5 ns rise/fall times, > 80 dB on/off ratio
- Built-in pulse generator features include variable pulse delay and width from 50 ns to 999 ms. This saves purchasing additional equipment.
- Leveled RF output maintains accuracy while in pulse modulation.

High reliability electronic attenuator (optional on 8644B)

For applications up to 1 GHz, the electronic attenuator provides increased reliability. Instead of using mechanical relays, the electronic attenuator uses solid-state components for setting output levels accurate to within ± 1.0 dB. The Agilent patented design uses PIN switching elements with three million hours of MTBF, giving the attenuator an estimated 0.2% failure rate.



Wideband FM (8664A and 8665B)

- Typical rates to 5 MHz with 2 MHz of deviation, or rates to 800 kHz with 10 MHz of deviation (f_c > 1500 MHz) allows testing of most wideband receivers.
- Excellent FM linearity is inherent due to YIG oscillator design.
- Stable dc-coupled FM for measurements that require low carrier drift.

Performance signal generator series features

- High stability oven controlled timebase is standard.
- Surface mount construction for improved reliability.
- Three year calibration cycle (MTBC) means less time in the calibration lab.
- Built-in self-diagnostics and calibration saves valuable time by significantly reducing down time.

2 GHz frequency counter (Option 8644B-011)

- 20 Hz to 2 GHz frequency counting via front panel connector.
- Cost and space efficient solution for applications involving audio frequency measurements, local oscillator, IF and transmitter testing.
- Eliminates the need to externally couple the timebase references when using an external counter.

Specifications

	8644B	8664A, 860	65B
Frequency			
Range:	0.252 to 1030 MHz	0.1 to 3000	MHz 8664A
3	0.252 to 2060 MHz, Option 8644B-002	0.1 to 6000	
Resolution:	0.01 Hz	0.01 Hz	2 00002
Accuracy (std. timebase):	0.375 x 10 ⁻⁶ times carrier in Hz	0.375 x 10 ⁻⁶ times carrier in Hz	
< 1 year of calibration	0.070 X TO THINGS GUITION IN THE	0.070 X 10	times carrier in 112
Switching speed (typical):	< 350 ms	< 50 ms (wi	thin 0.33 nnm)
(within 100 Hz)	< 550 III5	< 50 ms (within 0.33 ppm) < 100 ms 8664A-004 or 8665B-004	
(WICHIII 100 HZ)		< 100 IIIS 00	504A-004 01 0003B-004
Spectral purity			
SSB phase noise (dBc/Hz):			
(at 20 kHz offset)			
Carrier (MHz)		Standard	Option 004 (866xx-004)
4120 to 6000	NA	–105	-116
3000 to 4120	NA	-105	_122
2060 to 3000	NA	–111	_122
1030 to 2060	-130 (Option 8644B-002)	–111	-128
515 to 1030		–117 –117	-120 -134
	-136 (-142 typical)	–117 –122	-134 -139
257.5 to 515	-142 145		
128.5 to 257.5	-145 145	N/A	N/A
0.25 to 128.5	–145	N/A	N/A
8664A, 8665B	•••	400	
187.5 to 257.5	NA	-128	-144
0.1 to 187.5	NA	–117	–131
Nonharmonics:	< -105 dBc, > 10 kHz offset,	<-100 dBc	, > 10 kHz offset,
	0.252 to 1030 MHz	187.5 to 206	60 MHz
	<-100 dBc, >10 kHz offset,	< -90 dBc,	> 10 kHz offset,
	1030 to 2060 MHz		01 MHz, 0.1 to 187.5 MHz
Harmonics:	$<$ -25 dBc, output \le +10 dBm		output ≤ +10 dBm
Subharmonics:	None, 0.252 to 515 MHz		0.1 to 1500 MHz
odbilarii oliioo.	< –52 dBc, 515 to 1030 MHz		1500 to 3000 MHz
	< –40 dBc, 1030 to 2060 MHz		3000 to 60001 MHz
D : 1 15M/H)			
Residual FM (Hz rms):	Standard 3 kHz BW 15 kHz BW		Option 004 (866xx-004)
O / NALL_\	3 KHZ BVV 19 KHZ BVV	3 kHz BW	15 kHz BW
Carrier (MHz)		< 60/< 10	< 80/< 32
2060 to 60001			00/0
2060 to 60001 1030 to 2060	< 2 < 4	< 15/< 2.5	< 20/< 8
2060 to 60001 1030 to 2060 515 to 1030	< 1 < 2	< 15/< 2.5 < 7.5/< 1.2	< 10/< 4
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515	< 1 < 2 < 0.5 < 1	< 15/< 2.5	< 10/< 4
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5	< 1 < 2	< 15/< 2.5 < 7.5/< 1.2	< 10/< 4
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B	< 1 < 2 < 0.5 < 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 –	< 10/< 4 < 10/< 4 -
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5	< 1 < 2 < 0.5 < 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2	< 10/< 4 < 10/< 4 - < 10/< 4
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B	< 1 < 2 < 0.5 < 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 –	< 10/< 4 < 10/< 4 -
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5	<1 <2 <0.5 <1 <0.5 <0.5 <	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2 < 15/< 2.5	< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM:	< 1 < 2 < 0.5 < 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2	< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW)	<1 < 2 < 0.5 < 1 < 0.5 < 0.5 < 0.5 < 0.5 < 0.5	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - - < 7.5/< 1.2 < 15/< 2.5 < 0.04% AM	< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz):	< 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN	< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz):	<1 < 2 < 0.5 < 1 < 0.5 < 0.5 < 0.5 < 0.5 < 0.5	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN	< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz)	<1 < 2 < 0.5 < 1 < 0.5 < 0.5 < 0.01% AM rms < -157, 10 dBm, < 1030 MHz < -150, 10 dBm, < 2060 MHz	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 (< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz)	< 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 (< -150, 13 (< 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz high stability with EFC
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz)	< 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 - < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 (< -150, 13 (Option 001 ±3 x 10 ⁻¹⁰ /c	< 10/< 4 < 10/< 4 - 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz high stability with EFC lay after 10 days
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz) Internal reference oscillator Aging: Temperature:	< 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 (< -150, 13 (Option 001 ±3 x 10 ⁻¹⁰ /c ±6 x 10 ⁻¹⁰ , t	< 10/< 4 < 10/< 4 < 10/< 4 < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz high stability with EFC lay after 10 days o 55 °C
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz) Internal reference oscillator Aging: Temperature: Line voltage:	< 1 < 2 < 0.5 < 1 < 0.5 < 0.5 < 0.5 < 0.5 < 0.5	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 c < -150, 13 c Option 001 ±3 x 10 ⁻¹⁰ /c ±6 x 10 ⁻¹⁰ , t ±1 x 10 ⁻¹⁰ , t	< 10/< 4 < 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz dBm, > 187.5 MHz high stability with EFC lay after 10 days o 55 °C :10%
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz) Internal reference oscillator Aging: Temperature:	< 1	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 c < -150, 13 c Option 001 ±3 x 10 ⁻¹⁰ /c ±6 x 10 ⁻¹⁰ , t ±1 x 10 ⁻¹⁰ , t	< 10/< 4 < 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz high stability with EFC lay after 10 days o 55 °C
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz) Internal reference oscillator Aging: Temperature: Line voltage: Output:	< 1 < 2 < 0.5 < 1 < 0.5 < 0.5 < 0.5 $ < 0.01% AM rms$ $< -157, 10 dBm, < 1030 MHz$ $< -150, 10 dBm, < 2060 MHz$ Standard high stability $+1.5 \times 10^{-8}$ /day after ten days $+7 \times 10^{-10}$, 0 to 55 °C $\pm 2 \times 10^{-10}$, (+5%, -10%) 10 MHz , $> 0.15 \text{ V}_{rms}$ level into 50 Ω	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 o <-150, 13 o Option 001 ±3 x 10 ⁻¹⁰ /o ±6 x 10 ⁻¹⁰ , t ±1 x 10 ⁻¹⁰ , t ±1 x 10 ⁻¹⁰ , t 10 MHz, > 1	< 10/< 4 < 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz high stability with EFC lay after 10 days o 55 °C =10% I V _{rms} level into 50 Ω
2060 to 60001 1030 to 2060 515 to 1030 257.5 to 515 0.25 to 257.5 8664A, 8665B 187.5 to 257.5 0.1 to 187.5 Residual AM: (0.3 to 3 kHz post det. BW) SSB AM noise floor (dBc/Hz): (offsets > 100 kHz) Internal reference oscillator Aging: Temperature: Line voltage: Output: External reference input:	< 1 < 2 < 0.5 < 1 < 0.5 < 0.5 < 0.5 < 0.5 < 0.5	< 15/< 2.5 < 7.5/< 1.2 < 7.5/< 1.2 < 7.5/< 1.2 < 15/< 2.5 < 0.04% AN < -137, 13 o < -150, 13 o Option 001 ±3 x 10 ⁻¹⁰ /o ±6 x 10 ⁻¹⁰ , t ±1 x 10 ⁻¹⁰ , t 10 MHz, > 1	< 10/< 4 < 10/< 4 < 10/< 4 - < 10/< 4 < 20/< 8 1 rms dBm, < 187.5 MHz dBm, > 187.5 MHz high stability with EFC lay after 10 days o 55 °C =10% I V _{rms} level into 50 Ω

^{1. 3000} MHz for 8664A, 6000 MHz for 8665B

	8644B	8664A, 8665B	
Output level			
Range: +16 to -137 dBm, +13 dBm, 8644B-002/005		+13 to -139.9 dBm +9 dBm, Option 8664A-008 or 8665B-008	
Resolution:	0.01 Hz	0.01 Hz	. 00000
Absolute accuracy:	± 1 dB, output ≥ -127 dBm	± 1 dB, output ≥ -119.9 dBm, 1 - 1000 MHz	
•	±3 dB, output < –127 dBm	± 1.5 dB, output ≥ -119.9 dB ₁ ± 2 dB, output ≥ -119.9 dBm, ± 3 dB, output ≥ -129.9 dBm	n, 1000 to 3000 MHz
Reverse power protection:	50 watts	25 watts ² , 0.1 to 2060 MHz 1 watt, > 2060 MHz	
Third order intermod: (frequencies < 1300 MHz, two signals at +8 dBm, 25 kHz apart through a resistive combiner)	<-50 dBc	<-47 dBc	
Overrange:	Typically 2 dB	Typically 2 dB	
Switching speed (typical): SWR:	< 50 ms	< 50 ms	
Output level		< 3000 MHz ≥ 300	0 MHz
≥ 0 dBm	< 2.2:1	< 1.75:1 < 2.0:	
< 0 dBm	< 1.5:1	< 1.5:1 < 1.75	
Output impedance:	50 Ω	50 Ω	
Amplitude modulation			
Depth:	0 to 100%, output ≤ +7 dBm	0 to 100%, output \leq +7 dBm	
Resolution:	0.1%	0.1%	
Bandwidth (3 dB):	dc to > 100 kHz, > 128 MHz	dc to > 10 kHz for > 10 MHz	
Accuracy: 1 kHz rate	$\pm (7\% \text{ of setting } +1\%) \text{ up to } 80\% \text{ depth}$	\pm (6% of setting +1%) up to 9	90% depth
Distortion:	< 3%; < 4%, 8644B-002	< 4%	
30% depth, 1 kHz rate			
Incidental phase modulation:	< 0.2 radians peak	< 0.2 radians peak, ≤ 2000 N	lHz
(at 30% depth, 1 kHz rate)		< 0.2 radians peak, > 2000 N	lHz
External input impedance:	600 Ω	600 Ω	
Frequency modulation			
Maximum peak deviation:	20 MHz/200 kHz ³ , > 1030 MHz	20 MHz, 3000 to 60001 MHz	
	10 MHz/100 kHz ³ , > 515 MHz	10 MHz, 1500 to 3000 MHz	
	5 MHz/50 kHz ³ , > 257.5 MHz	5 MHz, 750 to 1500 MHz	
	2.5 MHz/25 kHz, > 128.5 MHz	2.5 MHz, 375 to 750 MHz	
	1.25 MHz/12.5 kHz ³ , > 64 MHz	1.25 MHz, 187.5 to 375 MHz	
	62.5 kHz/6.25 kHz³, > 32 MHz	5 MHz, < 187.5 MHz	
	Deviation halves per lower octave (> 16, > 8, > 4, > 2, > 1, > 0.5 MHz)		
Resolution:	2.5% of setting	2.5% of setting	
Bandwidth (3 dB):	dc to 100 kHz	dc to 800 kHz	
Carrier accuracy in FM:	±0.5% of setting	±0.6% of setting	
Indicator accuracy:	< 5%, < 30 kHz rates	±9%, < 20 kHz rates	
	< 10%, < 100 kHz rates	±11%, < 20 kHz rates, 8664A	-004 or 8665B-004
Distortion:	< 5%, < 1% ³ 20 Hz to 100 kHz	< 1%, 20 Hz to 20 kHz rates	
Incidental AM:	$< 0.5\%$, deviation $\le 20 \text{ kHz}$	$< 0.3\%$, deviation $\le 20 \text{ kHz}$	
External group delay:	$<$ 10 μ s, \le 100 kHz rates	< 30 μ s, \leq 2 0 kHz rates	
External input impedance:	600 Ω	600 Ω	

- 3000 MHz for 8664A, 6000 MHz for 8665B
 One watt on 8665B
- 3. Low noise mode three

ValueTronics International Inc. - www.valuetronics.com - Toll Free: 1.800.552.8258 or 1.847.468.8258 **Specifications (continued)**

	8644B	8664A, 8665B
Pulse modulation		Options 8664A-008 and 8665B-008
On/off ratio:	> 35 dB, > 80 dB, > 1030 MHz	> 80 dB
Rise/fall time, 10 to 90%:	< 100 ns	< 5 ns
Repetition rate:	dc to 1 MHz	dc to 10 MHz
Internal width/delay:	N/A	Variable from 50 ns to 1 s ±5%
		accuracy, 0.2% of full scale
		resolution
Minimum width:	0.5 μ s	10 ns
Video feedthrough/overshoot:	< 15%	< 25%
Output level accuracy:	±2 dB	Same as standard
External inputs/outputs:	Input level: on state; $> 3.0 V_{peak}$	Input level: TTL into 50 Ω or
	(600 Ω input impedance) off state; < 0.8 V_{peak}	Schottky TTL
		Sync out and video out: TTL
		into 50 Ω
Internal modulation source		
Number of sources:	Two sources simultaneously available through summ	
	modulation and pulse modulation to create a subcar	o be internally modulated with AM, FM, phase rier waveform.
Waveforms and rates:		
Waveforms and rates:	modulation and pulse modulation to create a subcar	
Waveforms and rates: Frequency accuracy:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz	
	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz	
Frequency accuracy: Output level (into 600 Ω): Output resolution:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1 \ V_{peak}, \ 2 \ V_{peak}$ for $8644B$ $2 \ mV_{peak}$	
Frequency accuracy: Output level (into 600 Ω):	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase 1 V _{peak} , 2 V _{peak} for 8644B	
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1 \ V_{peak}, \ 2 \ V_{peak}$ for $8644B$ $2 \ mV_{peak}$	
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak}\ 2\ V_{peak}\ for\ 8644B$ $2\ mV_{peak} < 0.1\%, \le 20\ kHz\ rates$	rier waveform.
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep Digital sweep:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak}\ 2\ V_{peak}\ for\ 8644B$ $2\ mV_{peak}$ $< 0.1\%, \le 20\ kHz\ rates$ Digitally stepped sweep over entire frequency range.	rier waveform. Linear/log selection. 0.5 to 1000 sec sweeps.
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep Digital sweep: Markers/Z axis output:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak},\ 2\ V_{peak}\ for\ 8644B$ $2\ mV_{peak}$ $< 0.1\%, \le 20\ kHz\ rates$ Digitally stepped sweep over entire frequency range. Three markers available /Z axis output nominally +5	Linear/log selection. 0.5 to 1000 sec sweeps. V/X axis output nominally 0 to 10 V.
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep Digital sweep:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak}\ 2\ V_{peak}\ for\ 8644B$ $2\ mV_{peak}$ $< 0.1\%, \le 20\ kHz\ rates$ Digitally stepped sweep over entire frequency range.	Linear/log selection. 0.5 to 1000 sec sweeps. V/X axis output nominally 0 to 10 V.
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep Digital sweep: Markers/Z axis output: Phase continuous sweep:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak},\ 2\ V_{peak}\ for\ 8644B$ $2\ mV_{peak}$ $< 0.1\%, \le 20\ kHz\ rates$ Digitally stepped sweep over entire frequency range. Three markers available /Z axis output nominally +5	Linear/log selection. 0.5 to 1000 sec sweeps. V/X axis output nominally 0 to 10 V.
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep Digital sweep: Markers/Z axis output:	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak},\ 2\ V_{peak}\ for\ 8644B$ $2\ mV_{peak}$ $< 0.1\%, \le 20\ kHz\ rates$ Digitally stepped sweep over entire frequency range. Three markers available /Z axis output nominally +5	Linear/log selection. 0.5 to 1000 sec sweeps. V/X axis output nominally 0 to 10 V.
Frequency accuracy: Output level (into 600 Ω): Output resolution: Total harmonic distortion: Frequency sweep Digital sweep: Markers/Z axis output: Phase continuous sweep: Remote programming	modulation and pulse modulation to create a subcard Sine, white Gaussian noise; 0.1 Hz to 400 kHz Triangle, sawtooth, square; 0.1 Hz to 50 kHz Same as timebase $1\ V_{peak}, \ 2\ V_{peak} \ for \ 8644B$ $2\ mV_{peak} < 0.1\%, \le 20\ kHz \ rates$ Digitally stepped sweep over entire frequency range. Three markers available /Z axis output nominally +5 40 MHz of span available at maximum carrier frequency	Linear/log selection. 0.5 to 1000 sec sweeps. V/X axis output nominally 0 to 10 V. ncy. Twenty ms to ten sec sweep times.

ValueTronics International Inc. - www.valuetronics.com - Toll Free: 1.800.552.8258 or 1.847.468.8258 **Specifications (continued)**

	8644B		8664A, 8665B
Avionics Option 8644B-0009	8644B-009 provides the performance needed for testing VOR		N/A
•	and ILS (localizer, glide slope and marker beacon) receivers.		
	8644B-009 provides quaranteed specifications necessary to		
	make these demanding tests.		
VOR (108 to 118 MHz)	Bearing accuracy: 0.1°, frequency accuracy: Same as timebase,		
,	AM accuracy (30%): ±5% of setting, AM distortion: 2%,		
	FM accuracy (480 Hz de	v.): ±1.5 Hz	
ILS: localizer/glide slope	DDM resolution:	Localizer: 0.0002 Glide slope: 0.0004	
(108 to 112 MHz/329.3 to	DDM accuracy:	Localizer: ±0.0004 ±5% of DDM	
335 MHz)		Glide slope: ±0.0008 ±5% of DDM	
Marker beacon (75 MHz):	AM accuracy: ±5% of so	etting AM distortion: 2%	
	AM accuracy (95%): ±5%	6 of setting +1% AM distortion: 5%	
2 GHz counter Option 011			
Frequency range:	20 Hz to 2 GHz in three	ranges	N/A
Sensitivity:	25 mV _{rms} (-19 dBm into	50 Ω)	
Maximum input:	$2.25 V_{ms}$ (+20 dBm into	50 Ω)	
Impedance:	50 Ω , 10 MHz to 2 GHz; 1 M Ω shunted by < 65 pf, < 10 MHz		
Coupling:	ac		
Gate times:	0.1s to 1s in 0.1s steps		
Measurement resolution:	Measured frequency (Hz) x 10 ⁻⁸ /gate time or 0.01 Hz if greater		
Measurement uncertainty: (± time base accuracy) plus (± measurement resolution)			

General

Power requirements: ±10% of 100 V, 120 V, 220 V or 240 V; 48 to 440 Hz; 500 VA except 8644B 400 VA.

Operating temperature: 0 to 55 °C

Leakage: Conducted and radiated interference meets MIL STD 461 B REO2 and FTZ 1046.

Leakage is measured into a resonant dipole antenna, one inch from the instrument's surface

with output level < 0 dBm (all inputs/outputs properly terminated, f_c < 1 GHz). Leakage is typically < 16 μV or < 2 μV with Option 010, measured at the front panel.

The older two-turn loop method of measurement is typically $< 1 \mu V$ or $< 0.1 \mu V$ for Option 010.

Acoustic noise: Typically < 5.5 bels

Storage registers: Ten full function and 40 frequency/amplitude registers.

Calibration/diagnostics: Internal calibration and diagnostics functions are available to the user. Built-in test capability

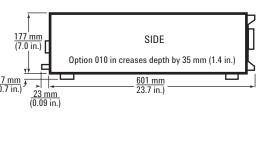
locates circuit malfunctions to allow repair through module replacement.

Calibration interval: Recommended three years (MTBC).

Weight: 8644B; 30 kg (67 lbs). 8664A/8665B; 35 kg (78 lbs)

Dimensions: 177H x 426W x 601D mm (7 x 16.8 x 23.7 in.). Option 010 adds 35 mm (1.4 in.) to depth.





Ordering information

Note: To add options to a product, specifiy the model number, followed by the option number. For example:

Models: 8644B, 8664A, 8665B

Option 8644A-005 or Option 8665B-010

		8644B	8664A 8665B
Options:			
001	High stability time base with EFC	✓	✓
002	2 GHz doubled output	✓	✓
003	Rear panel input/output	✓	✓
004	Low noise option	Not applicable	✓
005	Electronic attenuator (N/A with Option 002)	✓	✓
800	Pulse modulation	✓	✓
009	Specified VOR/ILS	✓	✓
010	Reduced leakage configuration	✓	✓
011	2 GHz internal frequency counter	✓	✓
907	Front handle kit (5061-9690)	✓	✓
908	Rack flange kit (5061-9678)	✓	✓
909	Combined front/rack flange kit (5061-9684)	✓	✓
915	Add service manual service kit	08645-61116	08665-61116
R1281A	Additional 3 years of return warranty	✓	✓



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